IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

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In a application of: Robert Malek, et al	§	Attorney Docket No. 26114.13
In the application of: Robert Malek, et al.	§	•
	§	Customer No. 27683
Serial No. 10/796,645	§	
	§	Group Art Unit: 2881
Filed: March 9, 2004	§	
	§	Examiner: Anthony G. Quash
For: MASS SPECTROMETER	§	·
	§	Confirmation No. 2185

Mail Stop Amendment Commissioner For Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

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Karen L. Underwood

FIFTH INFORMATION DISCLOSURE STATEMENT

Pursuant to the provisions of 37 C.F.R. §§ 1.56, 1.97 and 1.98, Applicants are filing this Information Disclosure Statement in order to cite some documents that may be material to the examination of this patent application, including a PCT Search Report from a related PCT application, and some art cited in that PCT Search Report. Each cited document is listed on enclosed Form PTO-1449 (modified), and Applicants are enclosing a copy of each cited document.

This Information Disclosure Statement is being filed under 37 C.F.R. §1.97(c), or in other words after mailing of a first Office Action on the merits, but before mailing of a communication that closes prosecution on the merits. In fact, this Information Disclosure Statement is being filed concurrently with a Response to the first Office

Action on the merits. An enclosed check includes the PTO fee of \$180.00 for submission of an Information Disclosure Statement at this point in the examination process.

It is respectfully requested that the Examiner (1) consider the documents cited on enclosed Form PTO-1449, (2) initial Form PTO-1449 for each listed document, and then (3) return a copy of the initialed PTO-1449 with the next PTO communication.

Date: 17 MARCH 2006 HAYNES AND BOONE, LLP 901 Main Street, Suite 3100

Dallas, Texas 75202-3789 Telephone: 972-739-6900 Facsimile: 214-200-0853

Respectfully submitted,

T. Murray Smith

Registration No. 30,222

(972) 739-8647

Enclosures: Form PTO-1449, and one copy of each listed document

Check (\$180.00)

Acknowledgement Post Card

R131182.1

Form PTO-1449 (modified)	U. S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	Complete if Known		
		Application Number	10/796,645	
INFO	RMATION DISCLOSURE	Filing Date	March 9, 2004	
STAT	TEMENT BY APPLICANT	Applicant(s)	Robert Malek, et al.	
	se as many sheets as necessary)	Art Unit	2881	
	MAR 2 0 2006	Examiner Name	Anthony G. Quash	
SHEET	1 OF 16	Attorney Docket Number	26114.13	

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U. S. PATENT DOCUMENTS				
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FOREIGN PATENT DOCUMENTS					
Examiner's Initials	Cite No.	Foreign Patent Document (Country Code – Number – Kind)	Publication Date	Patentee or Applicant of Cited Document	Translation

		OTHER DOCUMENTS	
Examiner's Cite Initials No.		Include name of the author, title of the article, title of the item, date, page(s), volume-issue number(s), publisher, city/country where published	
		PCT Search Report (Form PCT/ISA/ 210) issued by the European Patent Office in PCT Application No. PCT/EP2004/002486, 7 pages.	
		Senko, Michael W., et al., "External Accumulation of Ions for Enhanced Electrospray Ionization Fourier Transform Ion Cyclotron Resonance Mass Spectrometry", Journal of the American Society for Mass Spectrometry, Vol. 8, pages 970-976, 1997.	
	•	Alford, J.M., et al., "Metal Cluster Ion Cyclotron Resonance: Combining Supersonic Metal Cluster Beam Technology with FT-ICR", International Journal of Mass Spectrometry and Ion Processes, Vol. 72, pages 33-51, 1986.	
	-	Senko, Michael W., et al., "Electrospray Ionization Fourier Transform Ion Cyclotron Resonance at 9.4 T", Rapid Communications in Mass Spectrometry, Vol. 10, pages 1824-1828, 1996.	
		Beu, Steven C., "Fourier-Transform Electrospray Instrumentation for Tandem High-Resolution Mass Spectrometry of Large Molecules", Journal of the American Society for Mass Spectrometry, Vol. 4, pages 557-565, 1993.	

Examiner	Date	
Signature	Considered	

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include a copy of this form with next communication to applicant.

R-131183.1 Customer No. 000027683